

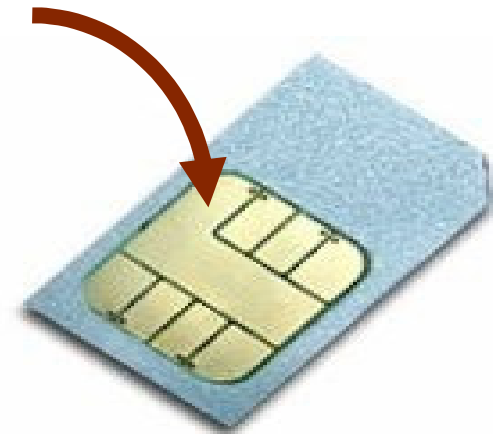
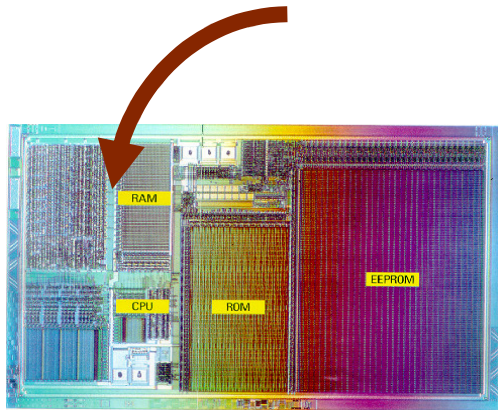


Security Challenges for High Density Smart Cards

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What is a traditional Smart Card?

A piece of Silicon and a Plastic body



Contains:

- millions of transistors
- RAM, ROM, EEPROM, FLASH and a CPU
- HW Crypto-coprocessors (DES, AES, RSA, DSA, ECC)

Applications: SIM cards, Credit Cards, Electronic Passport

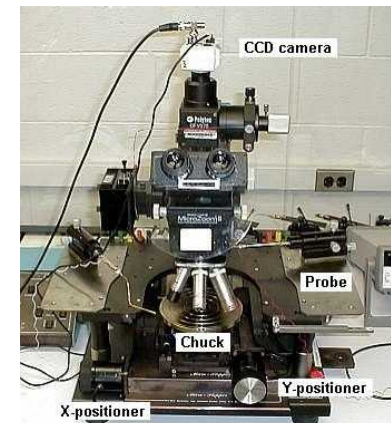
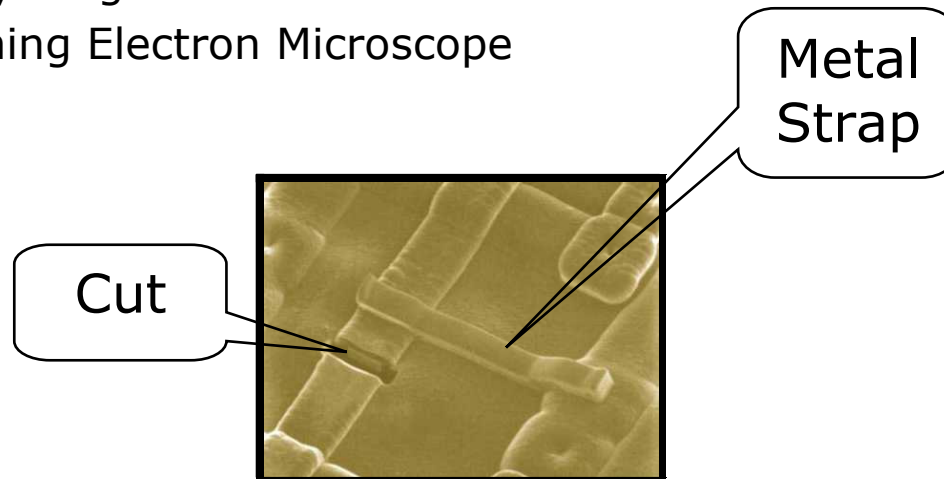
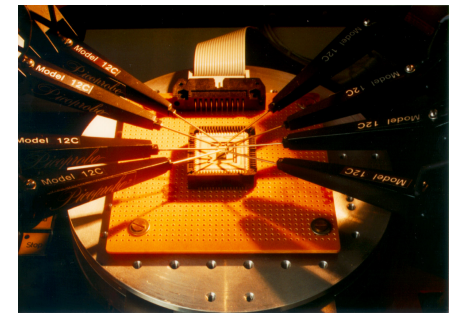
High Density vs Typical Smart Cards: Flash takes over...



	<i>Typical</i>	<i>High Density</i>
Confidential Operating system	ROM (512 KB)	CodeFlash (512 KB NOR Flash)
Application Data, Secret Keys	EEPROM (256 KB)	Emulated EEPROM (128 KB NOR FLASH)
RAM	5 KB	24, 48, 64 KB
User Data	In EEPROM	4 to 256 MB (OR) NAND FLASH
Interface	ISO 9600 bit/s	+ USB, MMC High-speed protocols
Die Size	25 mm ² in 0,13μm technology	75 mm ² in 90nm technology

Hardware Attacks : observing memory bits and buses

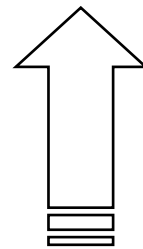
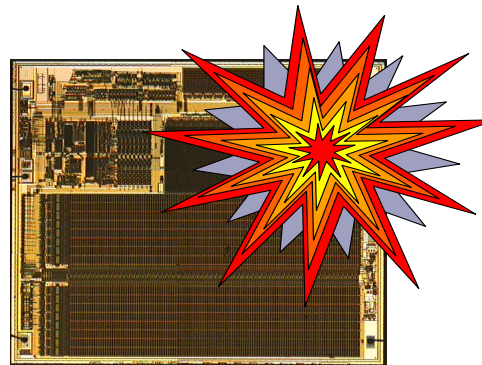
- Nanotechnologies will inherit typical invasive and semi-invasive attacks on Smart Cards
 - Chemical and Mechanical Etching
 - Decapsulation
 - Probing
 - Fibbing
 - De-layering
 - Scanning Electron Microscope



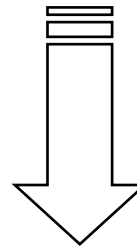
Fault Generation and Differential Fault Attacks

Out-of-range environmental conditions allow to bypass or infer secrets

- Vcc
- Glitch
- Clock
- Temperature
- UV
- Light Flashes
- X-Rays
- Lasers
- ...



input



error

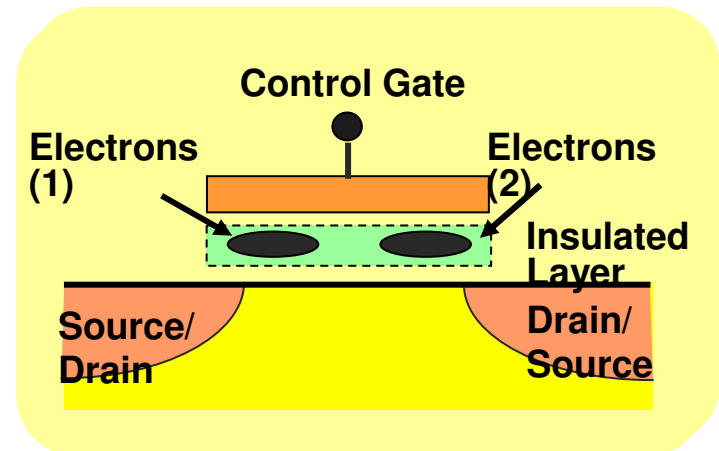
*one single
bit error
can break
RSA !*

High Density Flash Memory for Smart Cards



- Current Flash Technology for Smart Cards
 - 90 nm MirrorBit™ Technology
 - next generations: 65 nm, 45 nm, 32 nm
- Submitted to evaluation lab :
- Invasive attacks *much more difficult* on such small technology than on EEPROM, ROM
- Far *less error prone* when stressed (fault attacks).
- *More resources required* (time, knowledge, high precision tools) for successful invasive attacks.
- *But this may change over time ...*

MirrorBit™



Traps electrons on two sides of the insulated layer (2bit/cell)

Hardware Security Measures adapted from Secure Smart Card Design



- Security Sensors
(VCC, Temp, Light, UV, Clock, glitches)
- Shrinking technology scale
- Several Metal Layers
- Conductive metal shield
- Hand-routing of sensitive lines
- Deeply buried buses
- Glue Logic
- Current scramblers
- NOR FLASH Memory Scrambling:
 - Data scrambling
 - Address scrambling
- Generally a somewhat light encryption algorithm
- Has to be transparent in the architecture
- A few gates only, no delay but high security required (!)

New Security Challenges for Next generation High Density Cards

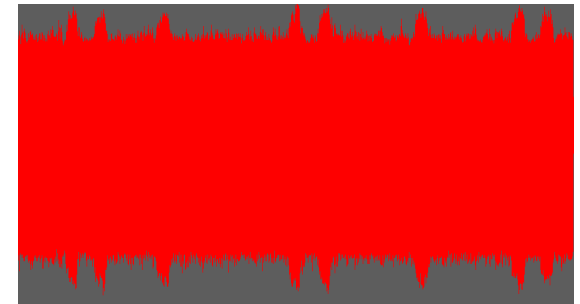


- On-the-fly encryption of Megabytes of data
 - high throughput encryption cores (3-5 Mbyte/s)
 - transparent for the user (as fast as USB/MMC protocols)
 - need to work in low power USIM mode too (below 10 mA)
- *Integrate everything on a Single Die*
 - Dual die solutions have an intrinsic security weakness (bus)
- Secure personalisation process for Flash
 - no more ROM for the sensitive operating system and algos
 - Initial Program Loader with Public Key capabilities required
 - highly secure memory scrambling is mandatory
- Security for One-Time-Programmable Flash sectors ?
- Secure Boot from CodeFlash

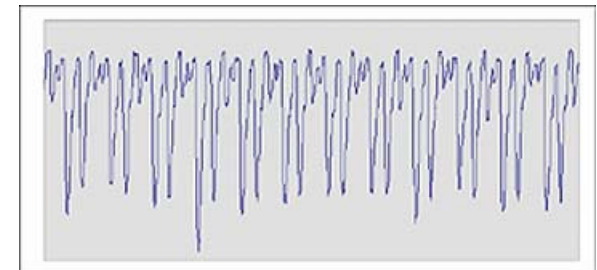
Side-Channel Attacks on Cryptographic Hardware:

Physical properties leak information

- Typical side-channels:
 - power consumption
 - timing information
 - electromagnetic radiation
 - radio-frequency analysis (Contactless, RFID)



- Information leakage:
 - depends on secret keys
 - can be measured
 - can be cryptanalysed by statistical methods



- *A few hundreds of power curves allow to retrieve cryptographic keys*

Countermeasures for Secret Key Algorithms (AES, DES)



- **Need to be built-in at design-level** (not add-on such as for RSA)
 - **clock jitter** or random desynchronization
 - increase **noise to signal ratio**
 - by random register pre-charging,
 - random operation interleaving, ...
 - **masking** intermediate data
 - multiplicative masking
 - masking at the gate level
 - **equalize power dissipation**: dual-rail logic, non-standard logic, requires full custom design
- Use additional **hardware security features**
 - current scramblers
 - noise generators

Technology
Dependent

A pink ribbon banner with a 3D effect, containing the text "Technology Dependent" in a black, sans-serif font.

Side-channel attacks in the real world...

There is still hope!



- Very difficult to obtain open access to devices to set-up template attacks
- Many concurrent countermeasures
- Hardware attacks mostly successful on open dedicated designs for evaluation purposes
 - Real attacks on fielded hardware still rare
 - ***More and more difficult as technology shrinks***
- CC: White-box analysis attacks compared to blackbox attacks in the field
- **Smart cards are not the only link in the security chain:**
 - back-end fraud detection systems
- **Security level is a trade-off**
 - as long as cost of fraud < cost of additional security measures, the issuer won't invest
 - Industry accepts a certain level of risk/cost

- Memory and Hardware Crypto cores are vulnerable to **physical and side-channel attacks**
 - Requires quite some **skills** for built-in security features
 - But: already many hardware security features available: ***transpose to nanotechnologies***
- ***As technology shrinks, attacks get more difficult***
- High Density concept for Smart Cards introduces new security challenges
- Security Features are always tested by evaluation labs
- Fine balance between **security and cost**

Thank you!

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